Direct Measurement of $P_{\mu}\xi$ at TWIST

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What is $P_{\mu}\xi$?

- P_{μ} is the polarization of the muon, and ξ is the asymmetry in angle of decay positrons from normal muon decay.

$$\frac{d^2\Gamma}{dxd\cos\theta} \propto \mathcal{F}_{\mathcal{IS}}(x,\rho,\eta) \pm \mathcal{P}_{\mu}\xi\cos\theta\mathcal{F}_{\mathcal{AS}}(x,\delta)$$



Motivation

 ξ and δ limit the probability of a right-handed muon decaying into any handed positron:

$$Q_R^{\mu} = \frac{1}{2}(1 + \frac{1}{3}\xi - \frac{16}{9}\xi\delta)$$

 - P_μξ sets limit on mass and mixing parameter in Left-Right Symmetric Models:

$$1 - \mathcal{P}_{\mu}\xi = 4\{\zeta^2 + \frac{M_1^4}{M_2^4} + \zeta\frac{M_1^2}{M_2^2}\}$$
$$\frac{3}{4} - \rho = \frac{3}{2}\zeta^2$$



Status of $P_{\mu}\xi$ Measurement

- Direct measurements:
 - $P_{\mu}\xi = 1.0027 \pm 0.0079 \pm 0.0030$

Beltrami et al, PL B194 (1987)

 $- P_{\mu} \xi \delta / \rho > 0.99682 \qquad (90\% \ c.l.)$ Jodidio et al, PR D34, PR D37 (1986)

Indirect measurement:

 $\label{eq:product} \begin{array}{l} - \; 0.9960 < \mathsf{P}_{\mu}\xi < \xi < 1.0040 \quad (90\% \; c.l.) \\ \\ TWIST, \; PRL\; 94,\; 101805 + PRD\; 71,\; 071101(R) \end{array}$

Experimental Setup



Muon Beam Characterization: Time Expansion Chamber

- 2 modules measure µ beam positions & divergences in X & Y directions.
- uncertainty in tracking: $\Delta x = 270.0 \ \mu m$, $\Delta \theta = 3.0 \ mrad$
- uncertainty in TEC position: $\Delta x = 2 \text{ mm}, \Delta \theta = 5.0 \text{ mrad}$



Evaluation of Systematic Uncertainties

Methodology

- Take data set or generate Monte Carlo runs under a condition that exaggerates possible sources of systematic error.
- Measure the effect on $(\rho, \eta, \xi, \xi\delta)$ by fitting two correlated data sets.
- Scale the effect by exaggeration factor.

Example

- Drift chamber time zero (t_0) might change during the data taking. What is the uncertainty in $P_{\mu}\xi$ due to the t_0 variation?
 - > analyze a data set with t_0 before the data collection (t_0^{begin}).
 - > analyze the same data with $t_0^{begin} + 10x(t_0^{end} t_0^{begin})$ (10x exaggeration).
 - hightarrow fit to each other: $\Delta P_{\mu} \xi = 8.9 \times 10^{-3}$
 - > divide the shift by exaggeration factor.

Summary of Systematic Uncertainties

- Muon Beam & Pol	3.69	
fringe field	3.40	
stopping target	1.40	
production target	0.21	
- Chamber Respons	0.98	
t0 variations	0.89	
foil bulges	0.22	
cell asymmetry	0.22	
up-down efficiency	0.19	
density	0.17	
- Spectrometer Alig	0.31	
rotations	0.22	
z position	0.22	
B field to axis	0.03	

- Positron Interactio	ns	0.30
hard interactions	0.29	
multiple scattering	0.08	
outside material	0.02	
- Momentum Calibra	0.19	
endpoint fits	0.16	
B field uniformity	0.09	
- Radiative Correcti	0.10	

Total Systematic Uncertainty: 3.80 x 10⁻³

Why is the Contribution from Fringe Field Big?

- Beam measurement by the TEC is not precise
 - > TEC efficiency is low, which causes a big uncertainty in the angle measurement and a bias in the position measurement.
 - > TEC calibration is not prefect.
 - > TEC alignment to the drift chamber is not monitored.
- Beam characterization runs are not consistent
 - > runs with "same settings" see a large difference in $\theta_{V.}$

Run	B2 (G)	$\overline{x}(\mathrm{cm})$	$\overline{y}(cm)$	$\overline{\theta_x}(\mathbf{mrad})$	$\overline{\theta_y}(\mathbf{mrad})$	P^{MC}_{μ}
18820	949	0.85	-1.1	0.87	-5.0	0.9955
18825	944	0.07	-5.9	0.97	7.0	0.9929
20565	949	0.94	-1.5	0.64	-19.2	0.9922
20558	944	0.06	-6.7	0.73	-11.2	0.9941

Result and Its Implication

 $P_{\mu}\xi = 1.0003 \pm 0.0006 \text{ (stat)} \pm 0.0038 \text{ (syst)}$

- Consistent with the Standard Model prediction of 1. Reduces the uncertainty by about a factor of two on the current PDG value = $1.0027 \pm 0.0079 \pm 0.0030$.
- Set new limits on muon handedness: $Q_R^{\mu} = \frac{1}{2}(1 + \frac{1}{3}\xi \frac{16}{9}\xi\delta)$



Summary and Outlook

- TWIST has completed its first direct measurement of P_μξ with 2004 data.
 The result reduces the uncertainty by a factor of ~2 on the PDG value.
- Largest systematic error is due to fringe field depolarization. Main reason is understood now. Improvements to the detector and beam line systems were made in 2005 data.
 - better calibration procedure
 - *TEC alignment was carefully monitored and well determined
- Anticipation to improve $P_{\mu}\xi$ measurement by another factor of 2 in the future should be reasonable .

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Extra Slides

Analysis Strategy

- Measure energy and angular distribution of decay positron
 - Reconstruct e⁺ track with helix fit and take into account multiple scattering and field non-uniformity.
 - Calibrate e⁺ energy to kinematic end point.
- Simulate detector acceptance with GEANT3
 - GEANT3 geometry contains virtually all detector components.
 - simulate detector response in detail (match TDC shape).
 - realistic, measured beam profile and divergence.
 - > muon pileup and beam e⁺ contamination.
- Extract Michel Parameters with blind analysis technique
 - > Monte Carlo data are generated using unknown, hidden values of (ρ , η , ξ , $\xi\delta$).
 - Final result kept hidden until the analysis is completed and systematic uncertainties evaluated.

Detector Array



- 56 chambers (44 DC+12 PC planes) symmetrically placed around the target.
- All planes precisely aligned rotationally and translationally.
- Beam stopping position carefully controlled by variable CO_2 /He gas degrader.

Radiative Corrections



- terms of $O(\alpha^2)$.
- Leading logarithmic terms of $O(\alpha^3)$.
- Corrections for soft pairs, virtual pairs, and an ad-hoc exponentiation.

Data Distribution



Extract the Michel Parameters

 Michel distribution is linear in ρ, η, ξ, and ξδ, so a fit to first order expansion is exact.

$$egin{aligned} n_i(oldsymbollpha_{ ext{data}}) &= n_i(oldsymbollpha_{ ext{MC}}) + rac{\partial n_i}{\partial lpha} \Delta lpha, \ oldsymbollpha &= [oldsymbol
ho, oldsymbol\eta, oldsymbol \xi, oldsymbol \delta] \end{aligned}$$

- Fit data (α_{data}) to sum of a base MC distribution (α_{MC}) plus MC-generated derivative distributions times fitting parameters (Δα) representing deviations from base MC.
- Can also fit data to data and MC to MC for systematic tests.







